

Notice of References Cited	Application/Control No. 10/706,366		Applicant(s)/Patent Under Reexamination TSUDA, HIDEAKI	
	Examiner (Nancy) Thanh-Nhan P. Nguyen		Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,621,550	09-2003	Arakawa et al.	349/178
*	B	US-RE38,288	10-2003	Yamada et al.	349/156
*	C	US-6,449,028	09-2002	Grupp et al.	349/191
*	D	US-2002/0039160	04-2002	Nam et al.	349/123
*	E	US-2002/0008836	01-2002	Shibahara, Hideo	349/155
*	F	US-2001/0026347	10-2001	Sawasaki et al.	349/156
*	G	US-5,729,318	03-1998	Yamada et al.	349/156
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.